

# INTERNATIONAL STANDARD

# NORME INTERNATIONALE



**Dielectric and resistive properties of solid insulating materials –  
Part 3-4: Determination of resistive properties (DC methods) – Volume  
resistance and volume resistivity at elevated temperatures**

**Propriétés diélectriques et résistives des matériaux isolants solides –  
Partie 3-4: Détermination des propriétés résistives (méthodes en courant  
continu) – Résistance transversale et résistivité transversale aux températures  
élevées**



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**DIELECTRIC AND RESISTIVE PROPERTIES OF SOLID  
INSULATING MATERIALS –****Part 3-4: Determination of resistive properties (DC methods) –  
Volume resistance and volume resistivity at elevated temperatures**

## FOREWORD

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International Standard IEC 62631-3-4 has been prepared by IEC technical committee 112: Evaluation and qualification of electrical insulating materials and systems.

This edition of IEC 62631-3-4 cancels and replaces IEC 60345 "Method of test for electrical resistance and resistivity of insulating materials at elevated temperatures", published in 1971. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to IEC 60345:

- a) The revised standard becomes part of the series IEC 62631-3-x. Title of the standard is changed and adapted to the series as Part 3-4.
- b) Clauses 2 "Normative references", 3 "Terms and definitions", and 4 "Significance" are added.

- c) Subclauses 5.2 "Power supply, Voltage", 5.3.1.2 "Number of test specimens" and 5.3.1.3 "Conditioning and pre-treatment of test specimens" are added.
- d) In 5.3.5 "Special precautions during measurements", errors analysis in the measurement of current are modified, and aligned with IEC 62631-3-1.
- e) In 6.2 "Increasing the temperature by steps (method B)", the method for more than one specimen is removed.
- f) The standard atmospheric conditions for testing and conditioning, especially the temperature, are replaced according to IEC 60212.
- g) The circuit diagram of test apparatus is modified, and the structure diagram and pictures of test apparatus are added in Annex A.
- h) The orders of part clauses are adjusted.

The text of this International Standard is based on the following documents:

CDV	Report on voting
112/406/CDV	112/445/RVC

Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 62631 series, published under the general title *Dielectric and resistive properties of solid insulating materials*, can be found on the IEC website.

The committee has decided that the contents of this document will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific document. At this date, the document will be

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- withdrawn,
- replaced by a revised edition, or
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# DIELECTRIC AND RESISTIVE PROPERTIES OF SOLID INSULATING MATERIALS –

## Part 3-4: Determination of resistive properties (DC methods) – Volume resistance and volume resistivity at elevated temperatures

### 1 Scope

This part of IEC 62631 covers procedures for the determination of insulation resistance and volume resistivity of insulating materials by applying DC-voltage and temperatures up to 800 °C. The typical application materials include high temperature mica plate and alumina ceramics.

### 2 Normative references

The following documents are referred to in the text in such a way that some or all of their content constitutes requirements of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60212:2010, *Standard conditions for use prior to and during the testing of solid electrical insulating materials*

IEC 62631-3-1, *Dielectric and resistive properties of solid insulating materials – Part 3-1: Determination of resistive properties (DC methods) – Volume resistance and volume resistivity – General method*

### 3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

ISO and IEC maintain terminological databases for use in standardization at the following addresses:

- IEC Electropedia: available at <http://www.electropedia.org/>
- ISO Online browsing platform: available at <http://www.iso.org/obp>

#### 3.1

##### **heating chamber**

device which is used for supplying an elevated temperature to the specimen

#### 3.2

##### **volume resistance**

part of the insulation resistance which is due to conduction through the volume

Note 1 to entry: Volume resistance is expressed in  $\Omega$ .

#### 3.3

##### **volume resistivity**

volume resistance of a material related to its volume

Note 1 to entry: Volume resistivity is expressed in  $\Omega\text{m}$ .

Note 2 to entry: For insulating materials, the volume resistivity is usually determined by means of measuring electrodes arranged on a sheet of the material.

Note 3 to entry: According to IEC 60050-121: Electromagnetism, "conductivity" is defined as the "scalar or tensor quantity, the product of which by the electric field strength in a medium is equal to the electric current density" and "resistivity" as the "inverse of the conductivity when this inverse exists". Measured in this way, the volume resistivity is an average of the resistivity over possible heterogeneities in the volume incorporated in the measurement; it includes the effect of possible polarization phenomena at the electrodes.

## 4 Significance

Some types of insulating materials are used under high temperatures up to 800 °C, such as mica plate and alumina ceramics, when mica plate is used for supporting aluminum electrolytic tank and alumina ceramics are used for high temperature crucibles or resistance furnace tubes.

For these purposes, it is generally desirable to have the insulation resistance as high as possible. Volume resistance and volume resistivity can be used as an aid in the choice of an insulating material for a specific application. The change in resistivity with temperature may be great and shall be known when designing for operation conditions.

## 5 Method of test

### 5.1 General

This method describes specific types of materials used at elevated temperatures; the typical upper temperature limit is 800 °C. Different types of electrodes can be used, depending on the specific measurement or product demands.

NOTE Thickness changes due to the high temperature can affect the measurement results.

### 5.2 Power supply and test voltages

A source of very steady DC voltage is required. This can be provided either by batteries or by rectified and stabilized power supply. The degree of stability required is such that the change in current due to any change in voltage is negligible compared with the current to be measured. Commonly specified test voltages to be applied to the complete specimen are 10 V, 100 V, 500 V, 1 000 V. If not otherwise stipulated, a voltage of 500 V shall be used.

### 5.3 Equipment

#### 5.3.1 Specimens and electrodes

##### 5.3.1.1 Preparation of specimens and electrodes

For insulation resistance measurements, the specimens shall be of any suitable size and shape and shall have electrodes already attached. When volume resistivity is measured, guarded electrodes are suggested. The preferred dimensions of test specimens shall be those given in the test procedures of IEC 62631-3-1. The specimen electrodes shall consist of fired-on conducting paint or a conducting coating evaporated or sprayed onto the specimen surfaces. Platinum is a suitable electrode material.

If other types of metal, such as silver or gold are used, make sure that they will not migrate into the sample or oxidize at test temperature.

The specimens shall be mounted securely among electrode backing plates within the heating chamber. These backing plates and their respective leads shall be made of a metal which is mechanically stable and resistive to oxidation. High-heat-resistant alloys such as stainless steel may also be utilized. The backing plates shall be of sufficient thickness to prevent warping and to provide heat equalization between the specimens and the electrode backing plates.



For mica plate and aluminium oxide specimen, a plate sample is recommended.

### 5.3.1.2 Number of test specimens

The number of specimens to be tested shall be determined by the relevant product standards. If no such data is available, at least three specimens shall be tested.

### 5.3.1.3 Conditioning and pre-treatment of test specimen

Conditioning and any other pre-treatment of the test specimen shall be done according to the relevant product standard. If no product standards exist, conditioning shall be done according to IEC 60212 standard conditions for use prior to and during the testing of solid electrical insulating materials.

### 5.3.2 Heating chamber

For heating the specimen, a suitable electric oven can normally be utilized up to 500 °C; a resistance furnace shall be used if the testing temperature reaches 800 °C. The construction shall be such that the specimen is subjected to a uniform temperature throughout its total volume with temperature fluctuations as small as possible. The atmospheric conditions for testing and conditioning shall be in accordance with IEC 60212. The samples shall be tested during the heat preservation period.

An adequate muffle should be provided to shield the specimen from direct radiation by the heating elements. This muffle may be made of a ceramic such as aluminum oxide or equivalent. A grounded metallic shield of stainless steel or equivalent metal shall also be provided within the oven. The shield shall act as a guard to prevent leakage currents between the heating circuit and the measuring circuit.

In the case of very high resistance specimens, it may be necessary to disconnect the heating element to prevent interference during the measurement.

A typical structure of heating chamber is shown in Annex A. Alternatively, the tests may be performed in an inert atmosphere.

### 5.3.3 Measuring leads

Insulated measuring leads shall be brought into the furnace through high-resistance ceramic insulators located in a cool zone and adequately guarded so as to prevent leakage current from affecting the test results.

NOTE Alternatively, the leads can be passed through holes in the top or in the wall of the furnace which is earthed. If stiff leads are used, they can be supported externally so as not to touch anything but their supports. The supports will be relatively cool and thus can be made of any rigid insulating material.

### 5.3.4 Temperature control

The temperature control mode of the heating chamber shall be set by program. A means of temperature control shall be provided which can maintain temperature tolerances according to IEC 60212 standard conditions for use prior to and during the testing of solid electrical insulating materials. The use of two thermocouples is recommended, one in the chamber for control and a second for the direct measurement of the specimen temperature.

The temperature of the specimen shall be measured using a thermocouple mounted as close as possible to the specimen without causing electrical interaction with the measurement of resistance. For example, the thermocouple may be inserted directly into a hole extending almost to the surface of the backing plate adjacent to the specimen. The hole can be drilled from the opposite face of the plate perpendicular to the surface of the specimen or from the side of the plate parallel to the specimen surface. If the thermocouple is mounted within the electrode backing plate, the leads and the temperature-indicating instrument shall be

adequately insulated or the thermocouple shall be disconnected or removed when measurements are made.

### 5.3.5 Special precautions during measurements

Errors in the measurement of current may result from the fact that the current-measuring device is shunted by the resistance between the guarded terminal and the guard system. To ensure satisfactory operation of the equipment, a measurement should be made with the lead from the voltage source to the specimen disconnected. Under this condition, the equipment should indicate infinite resistance within its sensitivity. If suitable standards of known values are available, they may be used to test the operation of the equipment.

If the material insulating the leads into the oven is subjected to heat, the insulation resistance of the lead insulation may become low enough to affect the measurements. The leakage resistance shall be determined by a separate measurement at each temperature. Thermocouple potentials between dissimilar metals, when they are used in leads and electrode holders, can cause measurement errors. A measurement of current, with the supply voltage replaced by a short circuit, will indicate the magnitude of this thermocouple effect.

## 5.4 Calibration

The equipment shall be calibrated in the magnitude of the volume resistance measured at room temperature.

NOTE Calibration resistors in the range up to 100 T $\Omega$  are commercially available.

## 6 Procedure

### 6.1 Continuously increasing temperature (method A)

This method is suitable for obtaining quickly an approximate relationship between resistance and temperature of a single specimen over a wide temperature range. The method is suitable only with materials for which the effects of dielectric absorption can be neglected, or for obtaining comparative results for similar materials. The specimen shall be mounted tightly between the electrode backing plates, but not so tightly that the specimen is distorted while being heated. The specified voltage shall be applied to the test specimen and the temperature shall be increased at a rate depending on the thickness of the material and not higher than 5 K/min. A sufficient number of resistance measurements shall be made, as the temperature is increased, so as to define adequately the relationship between resistance and temperature.

### 6.2 Increasing the temperature by steps (method B)

This method is suitable for obtaining the relationship between resistance and temperature of a single specimen more accurately than the one which is possible with continuously increasing temperature. It is useful also with specimens for which dielectric absorption is a problem.

The test specimen shall be mounted tightly between the electrode backing plates but not so tightly that the specimen is distorted while being heated. The temperature of the test specimen shall be increased from room temperature to the desired test temperature and subsequently from each test temperature step to the next.

NOTE 1 The test chamber is controlled in such a manner that the temperature of the electrode backing plate does not exceed the desired test temperature. Usually the temperature step is kept long enough to ensure the sample temperature meets the requirements in the high temperature range. If a temperature overshoot occurs, it will take some time to wait for the sample end temperature to meet the final test temperature.

When the temperature of the electrode backing plate is within the desired test temperature according to Table 2 of IEC 60212:2010, the voltage specified in the material specification shall be applied to the specimen for 1 min (or for other times as specified) and the resistance shall then be measured. When the measurement is completed, the voltage shall be removed

and the high voltage, measuring and guarded electrodes shall be connected to each other (short-circuited).

A sufficient number of test temperatures, but no less than five, shall be selected to define adequately the relationship between temperature and resistance over the desired range of temperatures. At the lower temperatures, the temperature increments should be relatively small, for example 10 K. As the test temperature is increased, the temperature increments should also be increased.

NOTE 2 The logarithm of resistance (or resistivity) is often plotted as a function of the reciprocal absolute temperature.

### 6.3 Precautions to be taken

When the current has not stabilized in the time specified for measurement, due to dielectric relaxation, it may be necessary to determine the resistance as a function of time so that the resistance value obtained at stabilization can be estimated.

When the resistance of the material being tested is relatively low, it may be necessary to make the measurements at a reduced voltage to avoid the effects of specimen heating.

For those materials in which polarization effects play a part, with concentration of ions at one or both electrodes, the results may be of doubtful value.

Unless the effect of thermal degradation is specially required, the specimen shall be kept at the test temperature only long enough to attain thermal equilibrium. The maximum permissible time of exposure to the test temperature should be determined by comparing values of resistance (one minute of electrification) measured periodically over a time, which are comparable to or longer than that expected in the tests (using an additional specimen).

After a series of tests at progressively higher temperatures, an additional measurement shall be made at the starting temperature to determine whether the exposure to the elevated temperatures has produced a permanent change in the specimens.

### 6.4 Calculation of volume resistivity

The volume resistivity shall be calculated from the following formula:

$$\rho = R_x \times A / h$$

where

- $\rho$  is the volume resistivity in  $\Omega\text{m}$ ;
- $R_x$  is the volume resistance measured in  $\Omega$ ;
- $A$  is the effective area of the electrode in  $\text{m}^2$ ;
- $h$  is the thickness of the specimen in m.

## 7 Report

The report shall include the following:

- complete identification and description of the material tested, including source and manufacturer's code;
- shape and thickness of test specimens;
- type of electrodes and nature of the electrode backing plates;
- test voltage and time of electrification;

- accuracy of the instrument and calibration method, depending on the measured values of resistance, if necessary;
- curing conditions of the material and any pre-treatment;
- conditioning of samples and climatic conditions under test;
- description of test set-up and instrument used for the test;
- number of samples;
- each single value and the median of volume resistance and volume resistivity respectively at each temperature;
- the method of increasing the temperature, i.e. method A or B;
- date of test;
- any other important observations if applicable.

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